## Notice of References Cited

Application/Control No. 10/723,378	Applicant(s)/Patent Under Reexamination CIRIGLIANO ET AL.		
Examiner	Art Unit		
Anthony Weier	1761	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,655,260	12-2003	Lazaris et al.	99/295
	В	US-2001/0052294	12-2001	Schmed, Arthur	99/295
	C	US-3,861,285	01-1975	Martin, John C.	99/295
	D	US-2002/0023543	02-2002	Schmed, Arthur	99/295
	Ε	US-6,649,045	11-2003	Tanner et al.	210/85
	F	US-6,182,554	02-2001	Beaulieu et al.	99/289R
	G	US-3,450,024	06-1969	MARTIN JOHN C	99/295
	Η,	US-2002/0048621	04-2002	Boyd et al.	426/77
	1	US-6,698,333	03-2004	Halliday et al.	99/295
	J	US-5,339,596	08-1994	Cohen, Zev B.	53/136.3
	K	US-5,717,307	02-1998	Barkat et al.	340/636.1
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α		1			
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

		TOTAL TO BOOMETTO
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.